

# Search Notes



Application/Control No.

10/800,867

Examiner

Nguyen N. Hanh

Applicant(s)/Patent under Reexamination

TAKENAKA ET AL.

Art Unit

2834

## SEARCHED

Class	Subclass	Date	Examiner
310	52	3/1/2006	HN
310	54	3/1/2006	HN
310	58	3/1/2006	HN
310	64	3/1/2006	HN
update	All	8/25/06	HIN
Search			
update	All	1/18/07	HN
search			

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
310	54	1/18/07	HIN

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
PG Pub Text Search, see interference search print out	1/18/07	HN
Consult Dang Le, Primary Examiner for Allowance	1/18/07	HN